Power MOSFET

40 V, 7.1 m Ω , 48 A, Single N-Channel

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

| Parar | Symbol | Value | Unit | | |
|--|------------------|----------------------------|-----------------------------------|----------------|----|
| Drain-to-Source Voltag | V _{DSS} | 40 | ٧ | | |
| Gate-to-Source Voltage | Э | | V _{GS} | ±20 | ٧ |
| Continuous Drain | | T _C = 25°C | I _D | 48 | Α |
| Current R _{θJC} (Notes 1, 2, 3, 4) | Steady | T _C = 100°C | | 27 | |
| Power Dissipation | State | T _C = 25°C | P_{D} | 38 | W |
| R _{θJC} (Notes 1, 2, 3) | | T _C = 100°C | 1 | 12 | |
| Continuous Drain | | T _A = 25°C | I _D | 14 | Α |
| Current R _{θJA} (Notes 1, 3, 4) | Steady State | T _A = 100°C | | 10 | |
| Power Dissipation | | T _A = 25°C | P_{D} | 3.1 | W |
| R _{θJA} (Notes 1, 3) | | T _A = 100°C | 1 | 1.5 | |
| Pulsed Drain Current | $T_A = 25^\circ$ | °C, t _p = 10 μs | I _{DM} | 193 | Α |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +175 | °C |
| Source Current (Body Diode) | | | IS | 31 | Α |
| Single Pulse Drain-to-S Energy (I _{L(pk)} = 2.9 A) | E _{AS} | 75 | mJ | | |
| Lead Temperature for S (1/8" from case for 10 s | TL | 260 | °C | | |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case - Steady State (Note 3) | $R_{\theta JC}$ | 4 | °C/W |
| Junction-to-Ambient - Steady State (Note 3) | $R_{\theta JA}$ | 48.6 | |

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

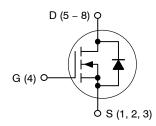


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| V _{(BR)DSS} | R _{DS(on)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 40 V | 8.5 m Ω @ 10 V | 48 A |

N-Channel





WDFN8 (μ8FL) CASE 511AB





08NC = Specific Device Code A = Assembly Location

Y = Year
WW = Work Week

Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|-----------------------------------|----------------------|--|------------------------|-----|------|-----|------|
| OFF CHARACTERISTICS | • | - | | | - | - | - |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | | 40 | | | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V. T _J = 25°C | | | | 10 | μΑ |
| | | V _{GS} = 0 V, V _{DS} = 40 V | T _J = 125°C | | | 250 | 1 |
| Gate-to-Source Leakage Current | I _{GSS} | $V_{DS} = 0 V, V_{G}$ | _S = 20 V | | | 100 | nA |
| ON CHARACTERISTICS (Note 5) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_{D}$ | = 30 μΑ | 2.5 | | 3.5 | V |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V, I _E | ₀ = 15 A | | 7.1 | 8.5 | mΩ |
| Forward Transconductance | 9FS | V _{DS} = 15 V, I _E | ₎ = 15 A | | 29 | | S |
| CHARGES AND CAPACITANCES | | | | | | | |
| Input Capacitance | C _{iss} | | | | 625 | | pF |
| Output Capacitance | C _{oss} | V _{GS} = 0 V, f = V _{DS} = 25 | 1.0 MHz, 5 V | | 335 | | 1 |
| Reverse Transfer Capacitance | C _{rss} | VDS - 20 V | | | 15 | | 1 |
| Threshold Gate Charge | Q _{G(TH)} | V _{GS} = 10 V, V _{DS} = 20 V, I _D = 15 A | | | 2.2 | | nC |
| Gate-to-Source Charge | Q_{GS} | | | | 3.5 | | |
| Gate-to-Drain Charge | Q_{GD} | | | | 1.8 | | |
| Total Gate Charge | Q _{G(TOT)} | $V_{GS} = 10 \text{ V}, V_{DS} = 20 \text{ V}, I_D = 15 \text{ A}$ | | | 10 | | nC |
| SWITCHING CHARACTERISTICS (No | te 6) | | | | | | |
| Turn-On Delay Time | t _{d(on)} | | | | 9.5 | | ns |
| Rise Time | t _r | V _{GS} = 10 V, V _D | s = 20 V, | | 24 | | |
| Turn-Off Delay Time | t _{d(off)} | I _D = 15 | Ă | | 19 | | 1 |
| Fall Time | t _f | | | | 6 | | 1 |
| DRAIN-SOURCE DIODE CHARACTER | RISTICS | | | | | | |
| Forward Diode Voltage | V _{SD} | V _{GS} = 0 V, | T _J = 25°C | | 0.84 | 1.2 | V |
| | | I _S = 15 A | T _J = 125°C | | 0.71 | | |
| Reverse Recovery Time | t _{RR} | | • | | 24 | | ns |
| Charge Time | t _a | $V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A/}\mu\text{s,}$ $I_S = 15 \text{ A}$ | | | 11 | | |
| Discharge Time | t _b | | | | 12 | | |
| Reverse Recovery Charge | Q _{RR} | | | | 11 | | nC |

^{5.} Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

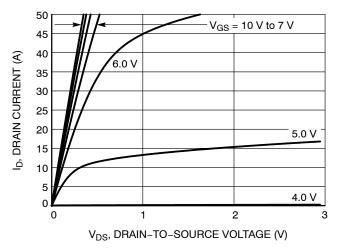


Figure 1. On-Region Characteristics

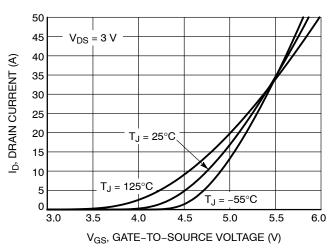


Figure 2. Transfer Characteristics

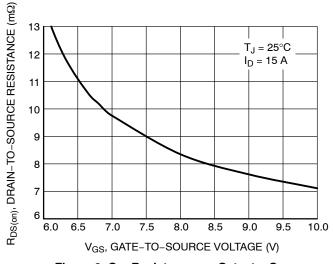


Figure 3. On-Resistance vs. Gate-to-Source Voltage

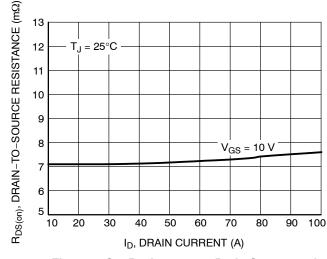


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

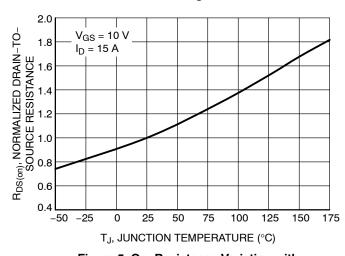


Figure 5. On–Resistance Variation with Temperature

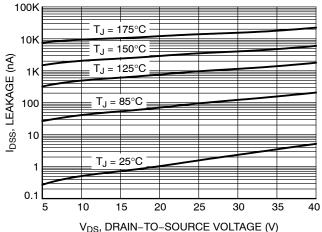


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

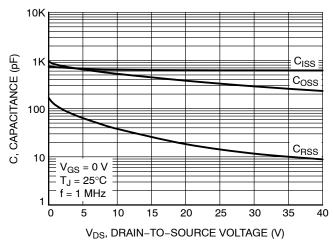


Figure 7. Capacitance Variation

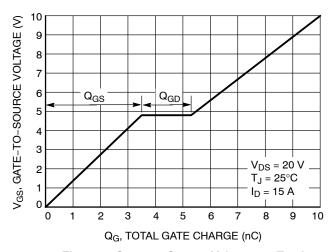


Figure 8. Gate-to-Source Voltage vs. Total Charge

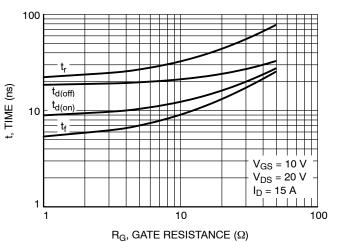


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

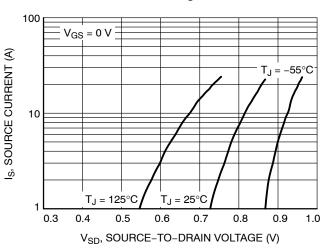


Figure 10. Diode Forward Voltage vs. Current

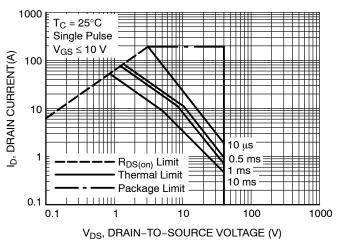


Figure 11. Maximum Rated Forward Biased Safe Operating Area

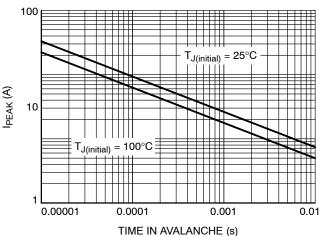


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

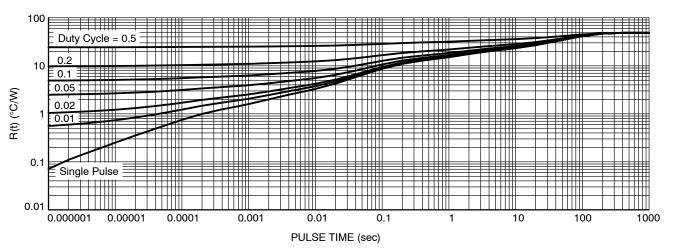


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

| Device | Marking | Package | Shipping [†] |
|-----------------|---------|--------------------|-----------------------|
| NTTFS008N04CTAG | 08NC | WDFN8 (Pb-Free) | 1500 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

| | MILLIMETERS | | | INCHES | | | |
|-----|--------------------|----------|------|-----------|-------|-------|--|
| DIM | MIN | NOM | MAX | MIN | NOM | MAX | |
| Α | 0.70 | 0.75 | 0.80 | 0.028 | 0.030 | 0.031 | |
| A1 | 0.00 | | 0.05 | 0.000 | | 0.002 | |
| b | 0.23 | 0.30 | 0.40 | 0.009 | 0.012 | 0.016 | |
| С | 0.15 | 0.20 | 0.25 | 0.006 | 0.008 | 0.010 | |
| D | 3.30 BSC 0.130 BSC | | | ; | | | |
| D1 | 2.95 | 3.05 | 3.15 | 0.116 | 0.120 | 0.124 | |
| D2 | 1.98 | 2.11 | 2.24 | 0.078 | 0.083 | 0.088 | |
| E | 3.30 BSC | | | 0.130 BSC | | | |
| E1 | 2.95 | 3.05 | 3.15 | 0.116 | 0.120 | 0.124 | |
| E2 | 1.47 | 1.60 | 1.73 | 0.058 | 0.063 | 0.068 | |
| E3 | 0.23 | 0.30 | 0.40 | 0.009 | 0.012 | 0.016 | |
| е | | 0.65 BSC | ; | 0.026 BSC | | | |
| G | 0.30 | 0.41 | 0.51 | 0.012 | 0.016 | 0.020 | |
| K | 0.65 | 0.80 | 0.95 | 0.026 | 0.032 | 0.037 | |
| L | 0.30 | 0.43 | 0.56 | 0.012 | 0.017 | 0.022 | |
| L1 | 0.06 | 0.13 | 0.20 | 0.002 | 0.005 | 0.008 | |
| М | 1.40 | 1.50 | 1.60 | 0.055 | 0.059 | 0.063 | |
| θ | 0 ° | | 12 ° | 0 ° | | 12 ° | |



GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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|------------------|----------------------|---|-------------|--|--|
| DESCRIPTION: | WDFN8 3.3X3.3, 0.65P | | PAGE 1 OF 1 | | |

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